

Search Notes

Application/Control No.

10/561,613

Examiner

Jennifer Y. Cho

Applicant(s)/Patent under
Reexamination

STUER ET AL.

Art Unit

1621

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
STIC Search	5/9/2007	JD
Inventor Search	5/9/2007	JD
East Search	6/5/2007	JC
Inventor Search	6/6/2007	JC